

Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

Claim 1 (Currently amended): A probe station for testing a device under test, said probe station comprising:

- (a) a first platen supporting an electrical probe engageable with a first surface of said device under test;
- (b) a chuck supporting said device under test;
- (c) a second platen having a top surface supporting thereon an optical probe to emit light for impingement on said device under test and, alternatively, to detect light emitted by said device under test toward said first platen and, ~~said light~~ propagating on an axis not substantially normal to said first surface;
- (d) said first platen positioned above said second platen and above said device under test;
- (e) at least 70% of the top surface of said second platen terminating in free space when said optical probe is not supported thereon.

Claim 2 (Original): The probe station of claim 1 wherein at least 80% of the top surface of said second platen terminating in free space when said optical probe is not supported thereon.

Claim 3 (Previously presented): The probe station of claim 1 wherein said first platen is supported for movement relative to said second platen.

Claim 4 (Original): The probe station of claim 1 wherein at least 85% of the top surface of said second platen terminating in free space when said optical probe is not supported thereon.

Claim 5 (Original): The probe station of claim 1 wherein at least 90% of the top surface of said second platen terminating in free space when said optical probe is not supported thereon.

Claim 6 (Original): The probe station of claim 1 wherein at least 95% of the top surface of said second platen terminating in free space when said optical probe is not supported thereon.

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Claim 7 (Original): The probe station of claim 1 wherein said second platen has a greater top surface area than said first platen.

Claim 8 (Original): The probe station of claim 1 wherein said second platen has a smaller top surface area than said first platen.

Claim 9 (Previously presented): The probe station of claim 1 wherein said second platen has the same surface area as said first platen.

Claim 10 (Original): The probe station of claim 1 wherein said first platen is maintained in position with respect to said second platen by gravity such that if said probe station were turned upside down said first platen would freely fall away from said second platen.